

**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT****Complete if Known**

Application No.	10/783,378
Filing Date	February 20, 2004
First Named Inventor	Hartmut Neven
Art Unit	2622
Examiner Name	Ngoc Yen T. Vu
Attorney Docket Number	24207-12225

Sheet

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of

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**U.S. PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	Document No. Number – Kind Code <sup>2</sup> (if known)	Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
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	A2	US-2003/0164819 A1	09-04-2003	Waibel
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Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document Country Code <sup>3</sup> – Number <sup>4</sup> Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	T <sup>6</sup>
	B1	WO 2005/114476 A1	12-01-2005	Nevengineering, Inc.	
	B2	WO 2004/038613 A1	05-06-2004	Softhouse Consulting Oresund AB	
	B3	WO 2003/001435 A1	01-03-2003	Emblaze Systems, Ltd.	
	B4	WO 2001/004790 A1	01-18-2001	Shlomo Urbach et al.	
	B5	EP 0 944 019 A2	09-22-1999	Hewlett-Packard Company	

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24207/12225/DOCS/1700776.1

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	B6	DE 101 10 979 A1	09-26-2002	Siemens AG	

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Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published			T <sup>6</sup>
	C1	BEIS, J. S., et al., "Shape Indexing Using Approximate Nearest-Neighbour Search in High-Dimensional Spaces," CVPR '97, 1997, 7 pages.			
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Examiner Signature	/Nicholas Giles/	Date Considered	03/06/2008
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